## Index of Claims 10810415 Examiner Chambliss, Alon

Application/Control No.	Applicant(s)/Patent Under Reexamination
10810415	LEINIKKA ET AL.
Examiner	Art Unit
Chambliss, Alonzo	2814

✓	Rejected	
=	Allowed	

-	Cancelled
÷	Restricted

N	Non-Elected
ı	Interference

Α	Appeal
0	Objected

Claims	renumbered	in the same o	rder as pr	esented by	applicant		☐ CPA	□ т.	D. 🗆	R.1.47
CL	AIM					DATE				
Final	Original	03/03/2008								
1	1	=								
2	2	=								
3	3	=								
4	4	=								
6	5	=								
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29	33	=								
30	34	=								
31	35	=								
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CLAIM DATE													
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☐ Claims	renumbered	in the same ord	der as pre	sented by a	applicant		☐ CPA	□ т.с	).	R.1.47
CL	AIM					DATE				
Final	Original	03/03/2008								
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35	40	=								
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